

<b>Notice of References Cited</b>	Application/Control No. 09/740,960	Applicant(s)/Patent Under Reexamination LEPPINEN ET AL.	
	Examiner Brandon J Miller	Art Unit 2683	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,574,733	06-2003	Langford, Glenn C.	713/194
	B	US-6,496,949	12-2002	Kanevsky et al.	714/47
	C	US-6,549,773	04-2003	Linden et al.	455/426.1
	D	US-6,421,673	07-2002	Caldwell et al.	707/10
	E	US-6,064,880	05-2000	Alanara, Seppo	455/419
	F	US-6,363,249	03-2002	Nordeman et al.	455/418
	G	US-6,230,082	05-2001	Harada et al.	701/1
	H	US-6,539,461	03-2003	Suzuki et al.	711/162
	I	US-6,714,952	03-2004	Dunham et al.	707/204
	J	US-6,414,146	07-2002	Takeyama et al.	544/221
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1158511 A2	11-2001	European Patent	LEIGH, DARREN L	G11B 19/04
	O	GB 2358556 A	07-2001	United Kingdom	KEE, JANG SEO	H04Q 07/32
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.